

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIP-256	SERIAL NO.	Jc872 U.S. PTO 10/07/02 02/21/02
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT K. ANAZAWA et al		
				FILING DATE February 21, 2002		
U.S. PATENT DOCUMENTS						
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (if Appropriate)
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
FOREIGN PATENT DOCUMENTS						
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
PL	AL 2000-105295	4/11/2000	Japan			<input type="checkbox"/> <input type="checkbox"/>
PL	AM 9-510784	10/28/97	Japan			<input type="checkbox"/> <input checked="" type="checkbox"/>
PL	AN W095/2655 5	10/5/95	WIPO			<input type="checkbox"/> <input type="checkbox"/>
	AO					<input type="checkbox"/> <input type="checkbox"/>
	AP					<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)						
	AR					
	AS					
	AT					
EXAMINER				DATE CONSIDERED 1/30/04		

* EXAMINER: Initial if reference considered; whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIP-256		SERIAL NO. 10/078,347	
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT K. ANAZAWA et al			
				FILING DATE February 21, 2002		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
AA							
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AK							
FOREIGN PATENT DOCUMENTS							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
PL	AL 7-253496	10/03/95	Japan			<input type="checkbox"/>	<input type="checkbox"/>
PL	AM 2000-346988	12/15/00	Japan			<input type="checkbox"/>	<input type="checkbox"/>
PL	AN 2001-74887	03/23/01	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
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EXAMINER				DATE CONSIDERED			

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1/30/04

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